Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination DEMEAUX, VINCENT	
Luan K. Bui	3728	

	SEAR	CHED	
Class	Subclass	Date	Examiner
206/	307-313	11/3/2006	LKB
211	40		
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	69.1	<u>.</u>	
40	401		
402	79, 501		
ABOVE	UPDATED	4/8/27	
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